

N-Channel 100 V (D-S) Power MOSFET

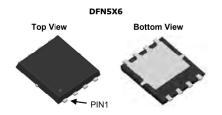
PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (mΩ)(Typ.)	I _D (A) ^{a, d}	Q _g (Typ.)		
100	12 at V _{GS} = 10 V	48	19 nC		

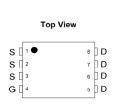
FEATURES

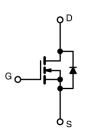
- DT-Trench Power MOSFET
- 100 % Rgand UIS Tested

APPLICATIONS

- DC/DC converters
- Primary side switch







N-Channel	MOSEET
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PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	100	V	
Gate-source voltage		V _{GS}	± 20	v	
-	T _C = 25 °C		48 ^a		
Continuous dusin surrent /T 150 °C\	T _C = 70 °C	1	35 ª		
Continuous drain current (T _J = 150 °C)	T _A = 25 °C	- I _D -	8.8 b, c		
	T _A = 70 °C		5.2 ^{b, c}		
Pulsed drain current (t = 100 μs)		I _{DM}	165	A	
Continuous source durin diede surrent	T _C = 25 °C	- I _S	48 ^a		
Continuous source-drain diode current	T _A = 25 °C		8.1 ^{b, c}		
Single pulse avalanche current	1 0.1 ml l	I _{AS}	45		
Single pulse avalanche energy L = 0.1 mH		E _{AS}	90	mJ	
	T _C = 25 °C		60		
Maximum navver dissination	T _C = 70 °C		47	w	
Maximum power dissipation	T _A = 25 °C	P _D	2.05 b, c	vv	
	T _A = 70 °C		1.6 b, c		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) c		1	260		

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum junction-to-ambient ^b	t ≤ 10 s	R_{thJA}	40	50			
Maximum junction-to-case	Steady state	R _{thJC}	1.2	2	°C/W		

- a. Based on T_C = 25 °C. b. Surface mounted on 1" x 1" FR4 board. c. t = 10 s.
- d. Calculated based on maximum junction temperature.



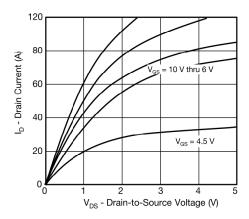
SPECIFICATIONS (T _J = 25 °C, u PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA	-	55	-	1	
V _{GS(th)} temperature coefficient	ΔV _{GS(th)} /T _J	I _D = 250 μA	-	-6	-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1	-	3	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	100	nA	
Zava state vallana dunin avunant		$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	μА	
Zero gate voltage drain current	IDSS	V _{DS} = 80 V, V _{GS} = 0 V, T _J = 75 °C	-	-	10		
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	48	-	-	Α	
Drain-source on-state resistance ^a	R _{DS(cn)}	V _{GS} =10 V, I _D = 20 A	-	12	18	mΩ	
Forward transconductance ^a	9 _{fs}	$V_{DS} = 5 \text{ V}, I_{D} = 20 \text{ A}$	-	38	-	S	
Dynamic ^b							
Input capacitance	C _{iss}		-	780	-	pF	
Output capacitance	Coss	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	110	-		
Reverse transfer capacitance	C _{rss}		-	9	-		
Total gate charge	Qg			19	-		
Gate-source charge	Q _{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	5	-	nC	
Gate-drain charge	Q _{gd}		-	3.3	-		
Gate resistance			-	1.2	-	Ω	
Turn-on delay time	t _{d(on)}		-	7.5	-		
Rise time	t _r	$V_{DD} = 50 \text{ V}, R_1 = 2.5 \Omega, I_D \approx 20 \text{ A},$	-	4	-	ns	
Turn-off delay time	t _{d(off)}	$V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	15	-		
Fall time	t _f		-	5	-		
Drain-Source Body Diode Characteristic	cs						
Continuous source-drain diode current	I _S	T _C = 25 °C	C 4		48		
Pulse diode forward current ($t_p = 100 \mu s$)	I _{SM}		-	-	165	A	
Body diode voltage	V _{SD}	I _S = 5 A, V _{GS} = 0 V	-	0.7	1.2	V	
Body diode reverse recovery time	dy diode reverse recovery time t _{rr}		-	34	-	ns	
Body diode reverse recovery charge	Q _{rr}	L 00 A di/dt 100 A/:- T 05 00	-	86	-	nC	
Reverse recovery fall time	ta	$I_F = 20 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-	17	-	ns	
Reverse recovery rise time	t _b		-	15	-		

- a. Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2 %
 b. Guaranteed by design, not subject to production testing

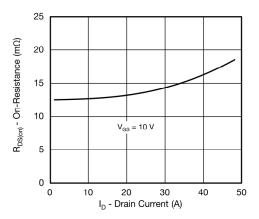
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



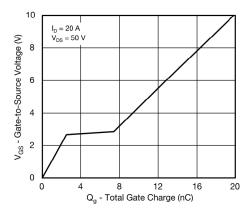
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



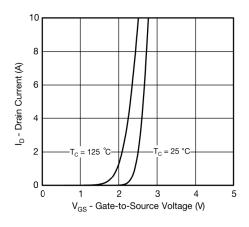
Output Characteristics



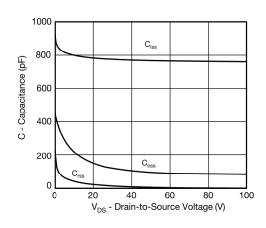
On-Resistance vs. Drain Current and Gate Voltage



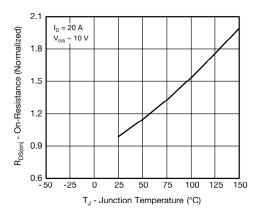
Gate Charge



Transfer Characteristics



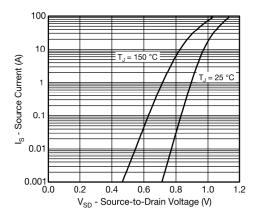
Capacitance



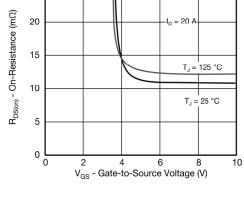
On-Resistance vs. Junction Temperature



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

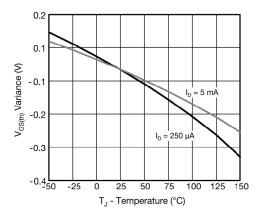


Source-Drain Diode Forward Voltage

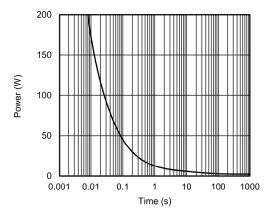


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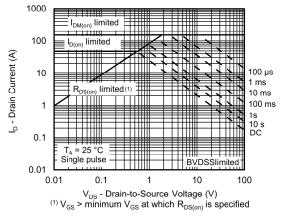
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



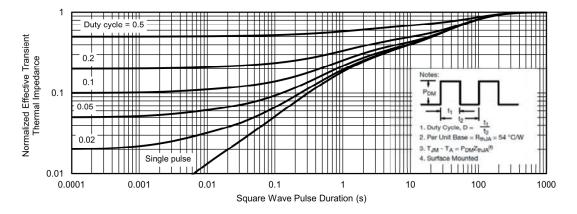
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient





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